



FORM PTO 1449 (modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATK DOCKET NO. 00684.103076		APPLICATION NO. 10/529,893	
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) July 21, 2006				APPLICANT Natsuhiko MIZUTANI			
				FILING DATE October 17, 2005		GROUP 1763 2851	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
ms		US-7,050,144 B2	05/23/2006	Mizutani et al.	355	19	
		2004/0121245 A1	06/24/2004	Inao et al.	430	5	
		2005/0063445 A1	03/24/2005	Mizutani et al.	372	94	
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED			
Michael Lin				6/28/07			

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		APPLICANT Natsuhiko MIZUTANI				
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)		FILING DATE April 1, 2005 10/17/05		GROUP Unassigned 2851		
May 3, 2005						
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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS SUBCLASS	FILING DATE IF APPROPRIATE
ms		US 6,171,730 B1	01/09/2001	Kuroda et al.	430 5	
↓		US 6,187,482 B1	02/13/2001	Kuroda et al.	430 5	
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ms		1 150 162 A2	10/31/2001	Europe		
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ms		International Search Report mailed February 7, 2005, issued in International Application No. PCT/JP2004/011648.				
↓		Written Opinion mailed February 7, 2005, issued in International Application No. PCT/JP2004/011648.				
↓		Alkaisi, Maan M., et al., "Nanolithography in the Evanescent Near Field," <u>Advanced Materials</u> , 13, No. 12-13, July 4, 2001, pp. 877-887.				
EXAMINER		DATE CONSIDERED				
ms		6/28/07				

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